

September 05, 2008

Datel Design & Development, Inc.
33 N. Garden Avenue, Suite 900,
Clearwater, FL 33755,
U.S.A.

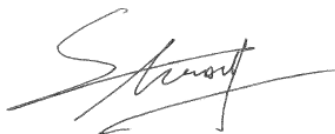
Dear Ken :

Enclosed you will find your file copy of a Part 15 Certification (FCC ID: WLE-DUS0269M0001).

For your reference, TCB will normally take another 20 days for reviewing the report. Approval will then be granted when no query is sorted.

Please contact me if you have any questions regarding the enclosed material.

Sincerely,

A handwritten signature in black ink, appearing to read "Shawn Xing", with a stylized flourish at the end.

Shawn Xing
Assistant Manager

Enclosure

Datel Design & Development, Inc.

Application
For
Certification
(FCC ID: WLE-DUS0269M0001)

Key Board for Wii Videogame Console

DUS0269

2.4GHz Transmitter



SZ08070300-1
Sam Dong
September 05, 2008

- The test results reported in this test report shall refer only to the sample actually tested and shall not refer or be deemed to refer to bulk from which such a sample may be said to have been obtained.
- This report is for the exclusive use of Intertek's Client and is provided pursuant to the agreement between Intertek and its Client. Intertek's responsibility and liability are limited to the terms and conditions of the agreement. Intertek assumes no liability to any party, other than to the Client in accordance with the agreement, for any loss, expense or damage occasioned by the use of this report. Only the Client is authorized to copy or distribute this report. Any use of the Intertek name or one of its marks for the sale or advertisement of the tested material, product or service must first be approved in writing by Intertek. The observations and test results referenced from this report are relevant only to the sample tested. This report by itself does not imply that the material, product, or service is or has ever been under an Intertek certification program.
- For Terms And Conditions of the services, it can be provided upon request.
- The evaluation data of the report will be kept for 3 years from the date of issuance.

TRF no.: FCC 15C_TXa
FCC ID: WLE-DUS0269M0001

INTERTEK TESTING SERVICES

LIST OF EXHIBITS

INTRODUCTION

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MEASUREMENT/TECHNICAL REPORT

Datel Design & Development, Inc. - MODEL: DUS0269

FCC ID: WLE-DUS0269M0001

September 05, 2008

This report concerns (check one:) Original Grant ☒ Class II Change ☐

Equipment Type: Low Power Transmitter (example: computer, printer, modem, etc.)

Deferred grant requested per 47 CFR 0.457(d)(1)(ii)? Yes ☐ No ☒

If yes, defer until: _____

date
Company Name agrees to notify the Commission by: _____

date
of the intended date of announcement of the product so that the grant can be issued on that date.

Transition Rules Request per 15.37? Yes ☐ No ☒

If no, assumed Part 15, Subpart C for intentional radiator - the new 47 CFR [9-20-07 Edition] provision.

Report prepared by:

Shawn Xing
Intertek Testing Services Shenzhen Ltd.
Kejiyuan Branch
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Nanshan District, Shenzhen, China.
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List of attached file

Exhibit type	File Description	Filename
Test Report	Test Report	report.pdf
Operation Description	Technical Description	descri.pdf
Test Setup Photo	Radiated Emission	radiated photos.doc
Test Report	Bandwidth Plot	bw.pdf
External Photo	External Photo	external photos.pdf
Internal Photo	Internal Photo	internal photos.pdf
Block Diagram	Block Diagram	block.pdf
Schematics	Circuit Diagram	circuit.pdf
ID Label/Location	Label Artwork and Location	label.pdf
User Manual	User Manual	manual.pdf
Cover Letter	Letter of Agency	letter.pdf
Cover Letter	Confidentiality Letter	request.pdf

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EXHIBIT 1

GENERAL DESCRIPTION

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1.0 **General Description**

1.1 Product Description

This Equipment Under Test (EUT) is the 2.4GHz wireless Keyboard. This EUT is powered by 2 AAA batteries. The main function of the EUT is used to transmit the 2.4GHz GFSK modulation signal to the USB dongle receiver that is sold together.

Antenna Type: PCB antenna

For electronic filing, the brief circuit description is saved with filename: descri.pdf.

1.2 Related Submittal(s) Grants

This is an application for certification of a transmitter. The receiver (PC peripherals), associated with this transmitter is subjected to certification procedure with FCC ID: WLE-DUS0269RM0001.

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1.3 Test Methodology

Radiated emission measurements were performed according to the procedures in ANSI C63.4 (2003). All measurements were performed in Semi-Anechoic Chamber. Preliminary scans were performed in the Semi-Anechoic Chamber only to determine worst case modes. For each scan, the procedure for maximizing emissions in Appendices D and E were followed. All Radiated tests were performed at an antenna to EUT distance of 3 meters, unless stated otherwise in the “**Justification Section**” of this Application.

1.4 Test Facility

The Semi-Anechoic Chamber facility used to collect the radiated data is **SHENZHEN ACADEMY OF METROLOGY & QUALITY INSPECTION** located at Longzhu Road, Shenzhen. This test facility and site measurement data have been fully placed on file with the FCC.

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EXHIBIT 2

SYSTEM TEST CONFIGURATION

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2.0 **System Test Configuration**

2.1 Justification

The system was configured for testing in a typical fashion (as a customer would normally use it), and in the confines as outlined in ANSI C63.4 (2003).

The EUT was powered from 2 * AAA Batteries.

For maximizing emissions below 30 MHz, the EUT was rotated through 360°, the centre of the loop antenna was placed 1 meter above the ground, and the antenna polarization was changed. For maximizing emission at and above 30 MHz, the EUT was rotated through 360°, the antenna height was varied from 1 meter to 4 meters above the ground plane, and the antenna polarization was changed. This step by step procedure for maximizing emissions led to the data report in Exhibit 3.0.

The unit was operated standalone and placed in the center of the turntable.

The equipment under test (EUT) was configured for testing in a typical fashion (as a customer would normally use it). The EUT was placed on a turn table, which enabled the engineer to maximize emissions through its placement in the three orthogonal axes.

When the unit is powered on, the unit will transmit continuously.

2.2 EUT Exercising Software

There was no special software to exercise the device. Once the batteries are installed, the unit transmits the typical signal continuously.

2.3 Special Accessories

No special accessories used.

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2.4 Equipment Modification

Any modifications installed previous to testing by Datel Design & Development, Inc. will be incorporated in each production model sold/leased in the United States.

No modifications were installed by Intertek Testing Services.

2.5 Measurement Uncertainty

When determining the test conclusion, the Measurement Uncertainty of test has been considered.

2.6 Support Equipment List and Description

This product was tested in a standalone configuration.

All the items listed under section 2.0 of this report are

Confirmed by:

*Shawn Xing
Assistant Manager
Intertek Testing Services Shenzhen Ltd. Kejiyuan Branch
Agent for Datel Design & Development, Inc.*



Signature

September 05, 2008 Date

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EXHIBIT 3

EMISSION RESULTS

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3.0 **Emission Results**

Data is included worst-case configuration (the configuration which resulted in the highest emission levels). A sample calculation, configuration photographs and data tables of the emissions are included.

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3.1 Field Strength Calculation

The field strength is calculated by adding the reading on the Spectrum Analyzer to the factors associated with preamplifiers (if any), antennas, cables, pulse desensitization and average factors (when specified limit is in average and measurements are made with peak detectors). A sample calculation is included below.

$$FS = RA + AF + CF - AG + PD + AV$$

Where FS = Field Strength in dB μ V/m
 RA = Receiver Amplitude (including preamplifier) in dB μ V
 CF = Cable Attenuation Factor in dB
 AF = Antenna Factor in dB
 AG = Amplifier Gain in dB
 PD = Pulse Desensitization in dB
 AV = Average Factor in -dB

In the radiated emission table which follows, the reading shown on the data table may reflect the preamplifier gain. An example of the calculations, where the reading does not reflect the preamplifier gain, follows:

$$FS = RA + AF + CF - AG + PD + AV$$

Assume a receiver reading of 62.0 dB μ V is obtained. The antenna factor of 7.4 dB and cable factor of 1.6 dB is added. The amplifier gain of 29 dB is subtracted. The pulse desensitization factor of the spectrum analyzer was 0 dB, and the resultant average factor was -10 dB. The net field strength for comparison to the appropriate emission limit is 32 dB μ V/m. This value in dB μ V/m was converted to its corresponding level in μ V/m.

RA = 62.0 dB μ V
AF = 7.4 dB
CF = 1.6 dB
AG = 29.0 dB
PD = 0 dB

AV = -10 dB

$$FS = 62 + 7.4 + 1.6 - 29 + 0 + (-10) = 32 \text{ dB}\mu\text{V/m}$$

$$\text{Level in } \mu\text{V/m} = \text{Common Antilogarithm } [(32 \text{ dB}\mu\text{V/m})/20] = 39.8 \mu\text{V/m}$$

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3.2 Radiated Emission Configuration Photograph

Worst Case Radiated Emission
at
2431.490 MHz

For electronic filing, the worst case radiated emission configuration photograph is saved with filename: radiated photos.doc.

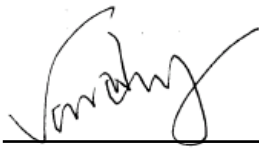
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3.3 Radiated Emission Data

The data on the following page lists the significant emission frequencies, the limit and the margin of compliance. Numbers with a minus sign are below the limit.

Judgement: Passed by 6.8 dB

TEST PERSONNEL:



Signature

Sam Dong, Compliance Engineer
Typed/Printed Name

September 05, 2008
Date

INTERTEK TESTING SERVICES

Applicant: Datel Design & Development, Inc.
Model: DUS0269

Date of Test: August 6, 2008

Table 1

Radiated Emissions

Polarization	Frequency (MHz)	Reading (dB μ V)	Pre-Amp Gain (dB)	Antenna Factor (dB)	Average Factor (-dB)	Net at 3m (dB μ V/m)	Limit at 3m (dB μ V/m)	Margin (dB)
Vertical	2400.000	19.8	20.0	28.5	--	28.3	54.0	-25.7
Horizontal	2431.420	76.2	20.0	28.5		84.7	94.0	-9.3
Vertical	2431.490	78.7	20.0	28.5	--	87.2	94.0	-6.8
Vertical	2714.679	30.1	20.0	28.5	--	38.6	54.0	-15.4
Vertical	*2483.500	20.4	20.0	28.5	--	28.9	54.0	-25.1
Vertical	*4862.975	26.4	20.0	32.5	--	38.9	54.0	-15.1
Vertical	*7294.126	22.2	20.0	36.3	--	38.5	54.0	-15.5

Notes: 1. Peak Detector Data unless otherwise stated.

2. All measurements were made at 3 meter. Harmonic emissions not detected at the 3-meter distance were measured at 0.3-meter and an inverse proportional extrapolation was performed to compare the signal level to the 3-meter limit. No other harmonic emissions than those reported were detected at a test distance of 0.3-meter.

3. Negative value in the margin column shows emission below limit.

4. Horn antenna is used for the emission over 1000MHz.

* Emission within the restricted band fulfil the requirement of Section 15.209. The corresponding limit as Section 15.209 is based on Quasi peak detector data for frequencies below 1000 MHz and average detector data for frequencies over 1000 MHz.

Test Engineer: Sam Dong

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EXHIBIT 4

EQUIPMENT PHOTOGRAPHS

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4.0 Equipment Photographs

For electronic filing, the photographs of the tested EUT are saved with filename: external photos.doc & internal photos.doc.

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EXHIBIT 5

PRODUCT LABELLING

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5.0 **Product Labelling**

For electronic filing, the FCC ID label artwork and the label location are saved with filename: label.pdf.

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EXHIBIT 6

TECHNICAL SPECIFICATIONS

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6.0 Technical Specifications

For electronic filing, the block diagram and schematics of the tested EUT are saved with filename: block.pdf and circuit.pdf respectively.

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EXHIBIT 7

INSTRUCTION MANUAL

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7.0 Instruction Manual

For electronic filing, a preliminary copy of the Instruction Manual is saved with filename: manual.pdf.

This manual will be provided to the end-user with each unit sold/leased in the United States.

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EXHIBIT 8

MISCELLANEOUS INFORMATION

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8.0 **Miscellaneous Information**

This miscellaneous information includes details of the measured bandwidth, the test procedure.

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8.1 Bandwidth Plot

Pursuant to FCC part 15 Section 15.215(c), the 20dB bandwidth of the emission was contained within the frequency band designated (mentioned as above) which the EUT operated. The effects, if any, from frequency sweeping, frequency hopping, other modulation techniques and frequency stability over excepted variations in temperature and supply voltage were considered.

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8.2 Emissions Test Procedures

The following is a description of the test procedure used by Intertek Testing Services in the measurements of transmitters operating under Part 15, Subpart C rules.

The test set-up and procedures described below are designed to meet the requirements of ANSI C63.4 - 2003.

The transmitting equipment under test (EUT) is placed on a wooden turntable which is four feet in diameter and approximately one meter in height above the ground plane. During the radiated emissions test, the turntable is rotated and any cables leaving the EUT are manipulated to find the configuration resulting in maximum emissions. The EUT is adjusted through all three orthogonal axes to obtain maximum emission levels. The antenna height and polarization are varied during the testing to search for maximum signal levels.

Detector function for radiated emissions is in peak mode. Average readings, when required, are taken by measuring the duty cycle of the equipment under test and subtracting the corresponding amount in dB from the measured peak readings.

The frequency range scanned is from the lowest radio frequency signal generated in the device which is greater than 9 kHz to the tenth harmonic of the highest fundamental frequency or 40 GHz, whichever is lower. For line conducted emissions, the range scanned is 150 kHz to 30 MHz.

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8.2 Emissions Test Procedures (cont'd)

The EUT is warmed up for 15 minutes prior to the test.

AC power to the unit is varied from 85% to 115% nominal and variation in the fundamental emission field strength is recorded. If battery powered, a new, fully charged battery is used.

Conducted measurements are made as described in ANSI C63.4 - 2003.

The IF bandwidth used for measurement of radiated signal strength was 10 kHz for emission below 30 MHz and 120 kHz for emission from 30 MHz to 1000 MHz. Where pulsed transmissions of short enough pulse duration warrant, a greater bandwidth is selected according to the recommendations of Hewlett Packard Application Note 150-2. Above 1000 MHz, a resolution bandwidth of 1 MHz is used.

Transmitter measurements are normally conducted at a measurement distance of three meters. However, to assure low enough noise floor in the restricted bands and above 1 GHz, signals are acquired at a distance of one meter or less. All measurements are extrapolated to three meters using inverse scaling, but those measurements taken at a closer distance are so marked.

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8.3 Discussion of Pulse Desensitization

The determination of pulse desensitivity was made in accordance with Hewlett Packard Application Note 150-2, *Spectrum Analysis ... Pulsed RF*.

The effective period (T_{eff}) was approximately 120 μ s. With a resolution bandwidth (3 dB) of 1MHz, the pulse desensitivity factor was 0 dB.